



DMN2400UFB4

20V N-CHANNEL ENHANCEMENT MODE MOSFET

Features

- Low On-Resistance
- Low Gate Threshold Voltage
- Low Input Capacitance
- Fast Switching Speed
- Low Input/Output Leakage
- Ultra-Small Surface Mount Package
- Ultra-Low Package Profile, 0.4mm Maximum Package Height
- Lead Free By Design/RoHS Compliant (Note 1)
- ESD Protected up to 1.5kV
- "Green" Device (Note 2)
- Qualified to AEC-Q101 standards for High Reliability

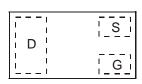
Mechanical Data

- Case: DFN1006H4-3
- Case Material: Molded Plastic, "Green" Molding Compound. UL Flammability Classification Rating 94V-0
- Moisture Sensitivity: Level 1 per J-STD-020
- Terminals: Finish NiPdAu over Copper leadframe. Solderable per MIL-STD-202, Method 208
- Weight: 0.001 grams (approximate)

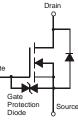
ESD PROTECTED TO 1.5kV



BOTTOM VIEW



TOP VIEW Package Pin Configuration



EQUIVALENT CIRCUIT

Ordering Information (Note 3)

Part Number	Marking	Reel size (inches)	Tape width (mm)	Quantity per reel
DMN2400UFB4-7	NC	7	8	3000
DMN2400UFB4-7B	NC	7	8	10,000

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Notes: 1. No purposefully added lead.

2. Diodes Inc.'s "Green" policy can be found on our website at http://www.diodes.com.

3. For packaging details, go to our website at http://www.diodes.com.

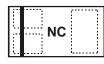
Marking Information

DMN2400UFB4-7



Top View Dot Denotes Drain Side

DMN2400UFB4-7B



Top View Bar Denotes Gate and Source Side NC = Product Type Marking Code



Maximum Ratings @T_A = 25°C unless otherwise specified

Characteristic			Symbol	Value	Units
Drain-Source Voltage			V _{DSS}	20	V
Gate-Source Voltage			V _{GSS}	±12	V
Continuous Drain Current (Note 4) V_{GS} = 4.5V	Steady State	T _A = 25°C T _A = 85°C	ID	0.75 0.55	A
Pulsed Drain Current (Notes 4 & 5)			I _{DM}	3	А

Thermal Characteristics @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Value	Units
Gliaracteristic	Symbol	value	Units
Total Power Dissipation (Note 4)	PD	0.47	mW
Thermal Resistance, Junction to Ambient	$R_{ ext{ heta}JA}$	258	°C/W
Operating and Storage Temperature Range	T _{J,} T _{STG}	-55 to +150	°C

Electrical Characteristics @T_A = 25°C unless otherwise specified

Characteristic	Symbol	Min	Тур	Max	Unit	Test Condition	
OFF CHARACTERISTICS (Note 6)							
Drain-Source Breakdown Voltage	BV _{DSS}	20	-	-	V	$V_{GS} = 0V, I_D = 250 \mu A$	
Zero Gate Voltage Drain Current $T_J = 25^{\circ}C$	I _{DSS}	-	-	100	nA	$V_{DS} = 20V, V_{GS} = 0V$	
Gate-Source Leakage	I _{GSS}	-	-	±1.0	μΑ	$V_{GS} = \pm 4.5 V$, $V_{DS} = 0 V$	
Gate-Source Leakage	I _{GSS}	-	-	±50	μΑ	$V_{GS} = \pm 10V, V_{DS} = 0V$	
ON CHARACTERISTICS (Note 6)							
Gate Threshold Voltage	V _{GS(th)}	0.5	-	0.9	V	$V_{DS} = V_{GS}$, $I_D = 250 \mu A$	
		-	-	0.55	Ω	$V_{GS} = 4.5V, I_D = 600mA$	
Static Drain-Source On-Resistance	R _{DS (ON)}	-	-	0.75		$V_{GS} = 2.5V, I_D = 500mA$	
		-	-	0.9		$V_{GS} = 1.8V, I_D = 350mA$	
Forward Transfer Admittance	Y _{fs}	-	1.0	-	S	$V_{DS} = 10V, I_D = 400mA$	
Diode Forward Voltage (Note 6)	V _{SD}		0.7	1.2	V	$V_{GS} = 0V, I_{S} = 150mA$	
DYNAMIC CHARACTERISTICS (Note 7)							
Input Capacitance	C _{iss}	-	36.0	-	pF		
Output Capacitance	Coss	-	5.7	-	pF	$V_{DS} = 16V, V_{GS} = 0V,$ - f = 1.0MHz	
Reverse Transfer Capacitance	C _{rss}	-	4.2	-	pF		
Total Gate Charge	Qg	-	0.5	-	nC	V _{GS} =4.5V, V _{DS} = 10V, ID =250mA	
Gate-Source Charge	Q _{gs}	-	0.07	-	nC		
Gate-Drain Charge	Q _{gd}	-	0.1	-	nC		
Turn-On Delay Time	t _{D(on)}	-	4.11	-	ns	$V_{DD} = 10V, V_{GS} = 4.5V,$ $R_L = 47\Omega, R_G = 10\Omega,$ $I_D = 200mA$	
Turn-On Rise Time	tr	-	3.82	-	ns		
Turn-Off Delay Time	t _{D(off)}	-	14.8	-	ns		
Turn-Off Fall Time	t _f	-	9.6	-	ns		

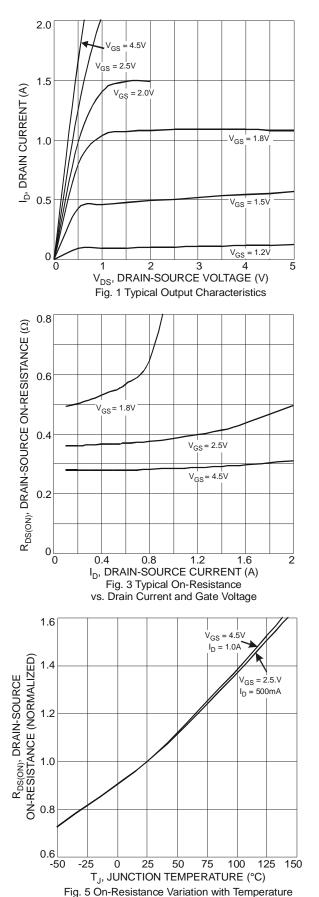
4. Device mounted on FR-4 PCB, with minimum recommended pad layout, single sided. Notes:

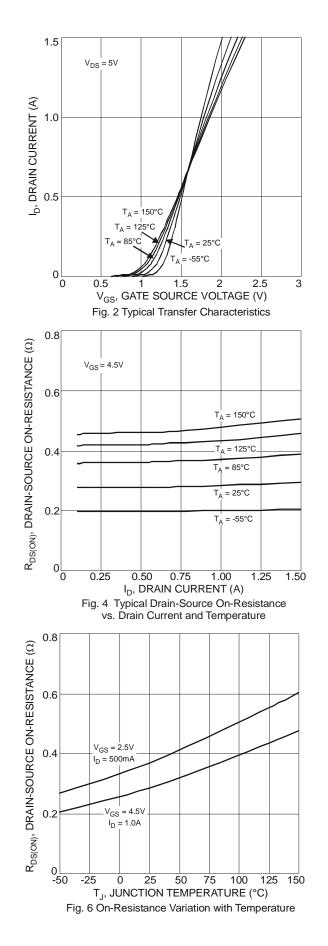
5. Device mounted on minimum recommended pad layout test board, 10µs pulse duty cycle = 1%.

6. Short duration pulse test used to minimize self-heating effect.
7. Guaranteed by design. Not subject to product testing.

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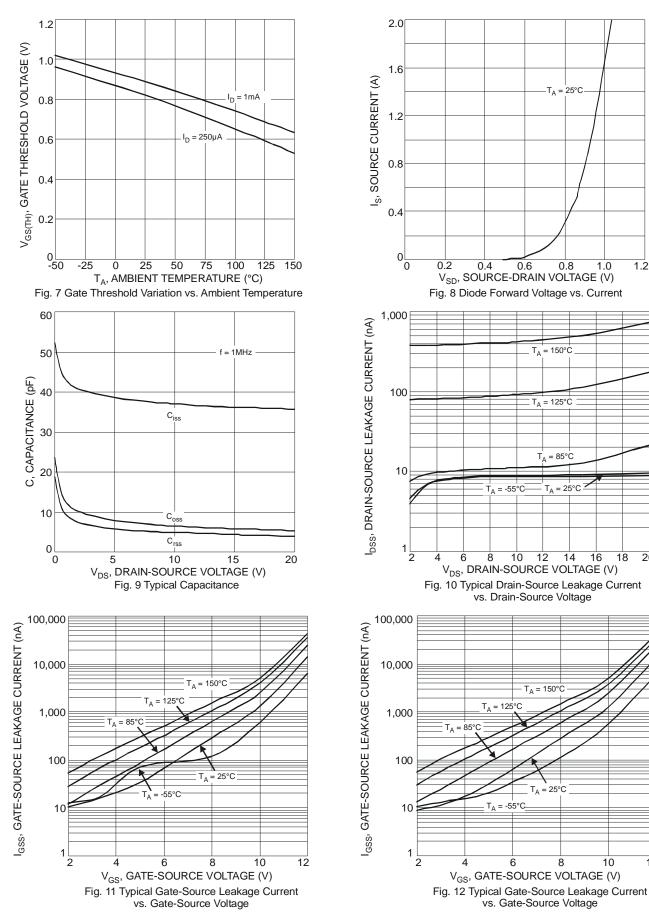
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1.2

18 20

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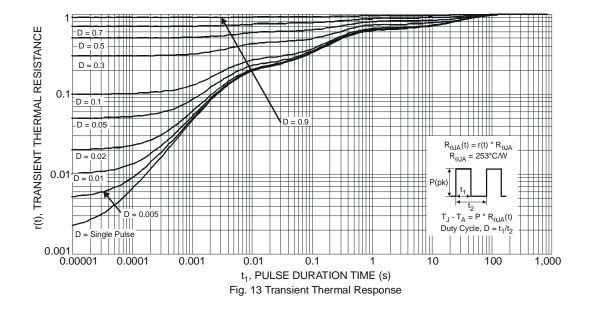




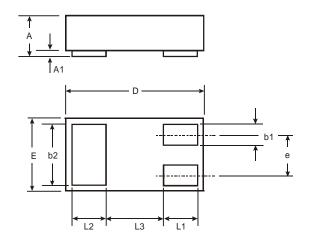
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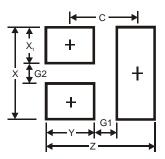


Package Outline Dimensions



DFN1006H4-3						
Dim	Min	Max	Тур			
Α		0.40	_			
A1	0	0.05	0.02			
b1	0.10	0.20	0.15			
b2	0.45	0.55	0.50			
D	0.95	1.075	1.00			
Е	0.55	0.675	0.60			
е	—	—	0.35			
L1	0.20	0.30	0.25			
L2	0.20	0.30	0.25			
L3			0.40			
All Dimensions in mm						

Suggested Pad Layout



Dimensions	Value (in mm)
Z	1.1
G1	0.3
G2	0.2
Х	0.7
X1	0.25
Y	0.4
С	0.7



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